

# Product Standards

勝特力材料 886-3-5753170  
勝特力电子(上海) 86-21-34970699  
勝特力电子(深圳) 86-755-83298787  
[Http://www.100y.com.tw](http://www.100y.com.tw)

## PGA26E07BA

Type	GaN-Tr		
Application	For power switching		
Structure	N-channel enhancement mode FET		
Equivalent Circuit	Figure 1		
Out Line	DFN 8X8	Marking	PGA26E07

**A. ABSOLUTE MAXIMUM RATINGS ( T<sub>j</sub> = 25 °C , unless otherwise specified )**

No.	Item	Symbol	Values			Unit	Note
			Min.	Typ.	Max.		
1	Drain-source voltage ( DC ) *1	VDSS	-	-	600	V	
2	Drain-source voltage ( pulse ) *2	VDSP	-	-	750	V	
3	Gate-source voltage ( DC ) *1	VGSS	-10	-	-	V	*VGSS+ is given by IG ratings *See application note
4	Gate current ( DC ) *1	IG	-	-	50	mA	*See application note
5	Gate current ( pulse ) *3,4	IGP	-	-	1.5	A	*See application note
6	Electric gate charge	QGP	-	-	32	nC	*f=200kHz *See application note
7	Drain current ( DC ) ( T <sub>c</sub> = 25 °C ) *1	ID	-	-	26	A	Figure 4
8	Drain reverse current ( DC ) ( T <sub>c</sub> = 25 °C ) *1	IDR	-	-	26	A	
9	Drain current ( pulse ) *5 ( T <sub>c</sub> = 25 °C ) *1	ID pulse	-	-	61	A	Figure 4
10	Drain reverse current ( pulse ) *5 ( T <sub>c</sub> = 25 °C ) *1	IDR pulse	-	-	61	A	
11	Power dissipation ( T <sub>c</sub> = 25 °C )	PD	-	-	96	W	Figure 2
12	Junction temperature	T <sub>j</sub>	-	-	150	°C	
13	Storage temperature	T <sub>stg</sub>	-55	-	150	°C	
14	Drain-source voltage slope	dv/dt	-	-	200	V/ns	

[Special instructions]

\*1 : Please use this product to meet a condition of T<sub>j</sub> within 150 °C.

\*2 : Spike duty cycle D < 0.1, spike duration < 1us, total spike time < 1 hour.

\*3 : IGP is defined as (V<sub>cc</sub> - V<sub>plateau</sub>) / R<sub>gon</sub>, as shown in Figure A.

V<sub>plateau</sub> is the voltage between Gate and Source1.

\*4 : Please use this product to meet both a maximum gate current and a maximum gate pulse charge of IGP(1.5A) and Q(32nC) respectively, as shown in Figure H.

\*5 : Pulse width limited by T<sub>jmax</sub>.

**B. ELECTRICAL CHARACTERISTICS (T<sub>j</sub> = 25 °C, unless otherwise specified)**

No.	Item	Symbol	Measurement Condition	Min.	Typ.	Max.	Unit
1	Drain cut-off current	IDSS	VDS=600 V, VGS=0 V, Tj=25 °C	-	-	100	μA
			VDS=600 V, VGS=0 V, Tj=150 °C	-	100	-	μA
2	Gate-source leakage current	IGSS	VGS=-3 V VDS=0 V	-1	-	-	μA
3	Gate forward voltage	VGSF	IGS=26.1 mA open drain	2.8	3.5	4.2	V
4	Gate threshold voltage	VTH	VDS=10 V IDS=2.6 mA	0.9	1.2	1.6	V
5	Drain-source on-state resistance	RDS(on)	IGS=26.1 mA, IDS=8A, Tj=25 °C	-	56	70	mΩ
			IGS=26.1 mA, IDS=8 A, Tj=150 °C	-	110	-	mΩ
6	Gate resistance	RG	f=100MHz open drain	-	0.6	-	Ω
7	Transfer conductance	gfs	VDS=8 V IDS=8 A	-	32	-	S
8	Input capacitance	Ciss		-	405	-	pF
9	Output capacitance	Coss	VDS=400 V VGS=0 V f=1 MHz	-	71	-	pF
10	Reverse transfer capacitance	Crss		-	0.4	-	pF
11	Turn-on delay time	td(on)	VDD=400 V	-	3.7	-	ns
12	Rise time	tr	IDS=8 A (Figure A, Figure B)	-	5.6	-	ns
13	Turn-off delay time	td(off)	Vcc=12 V Rgon=6.2 Ω, Rgoff=4.7 Ω,	-	5.5	-	ns
14	Fall time	tf	Rig=680 Ω, Cs=1500 pF	-	2.4	-	ns
15	Effective output capacitance ( energy related )	Co(er)		-	87	-	pF
16	Effective output capacitance ( time related )	Co(tr)	VDS=0-480 V	-	106	-	pF

**C. GATE CHARGE CHARACTERISTICS ( T<sub>j</sub> = 25 °C, unless otherwise specified )**

No.	Item	Symbol	Measurement Condition	Min.	Typ.	Max.	Unit
1	Gate charge	Qg	VDD=400 V IDS=8 A (Figure C, Figure D)	-	5.0	-	nC
2	Gate-source charge	Qgs		-	0.9	-	nC
3	Gate-drain charge	Qgd		-	2.6	-	nC
4	Gate plateau voltage	V plateau	VDD=400 V IDS=8 A	-	1.7	-	V

**D. REVERSE CONDUCTING CHARACTERISTICS ( T<sub>j</sub> = 25 °C, unless otherwise specified )**

No.	Item	Symbol	Measurement Condition	Min.	Typ.	Max.	Unit
1	Source-drain forward voltage	VSD	VGS=0 V ISD=8 A	-	2.1	-	V
2	Reverse recovery charge	Qrr	VDS=400 V ISD=8 A	-	0	-	nC
3	Reverse recovery time	trr		-	0	-	ns
4	Peak reverse recovery current	Irrm		-	0	-	A
5	Output charge	Qoss		-	45	-	nC

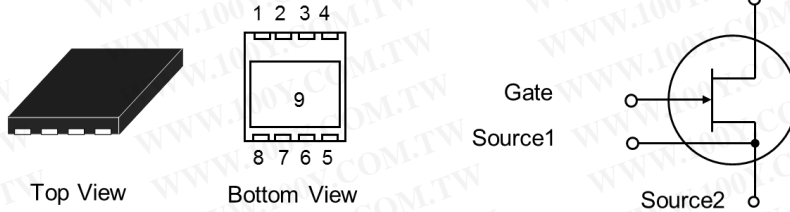
**E. THERMAL RESISTANCE CHARACTERISTICS**

No.	Item	Symbol	Measurement Condition	Min.	Typ.	Max.	Unit
1	Thermal resistance ( junction to case )	Rth(j-c)		-	-	1.3	°C/W
2	Thermal resistance ( junction to ambient ) *1	Rth(j-a)		-	-	46	°C/W
3	Reflow soldering temperature	Tsold	reflow MSL3	-	-	260	°C

## [Notes]

\*1 : Device mounted on four layers epoxy PCB (6.45 cm<sup>2</sup> copper area and 70 μm thickness).

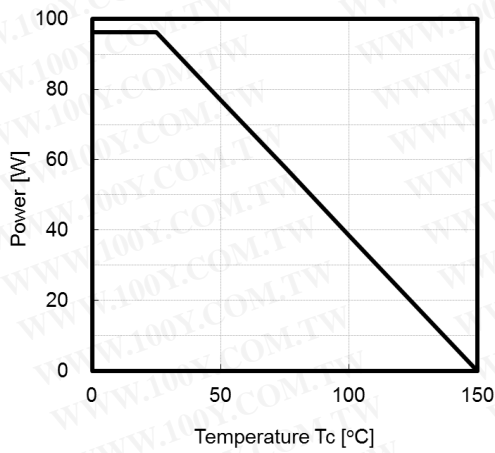
■ Equivalent circuit / Electrical characteristics



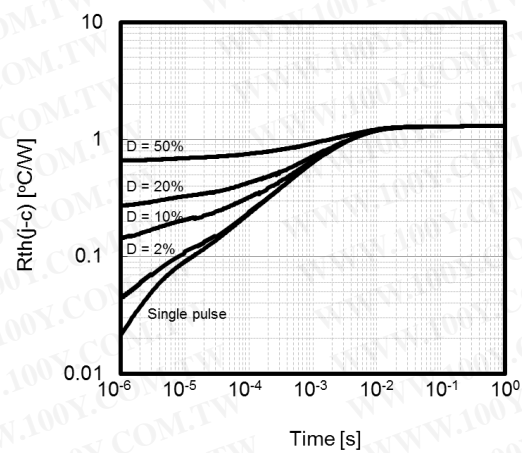
- 1,2,3,4 : Drain
- 5,6,9 : Source2
- 7 : Source1
- 8 : Gate

Notice:  
Please connect Source1 pin to gate driver.

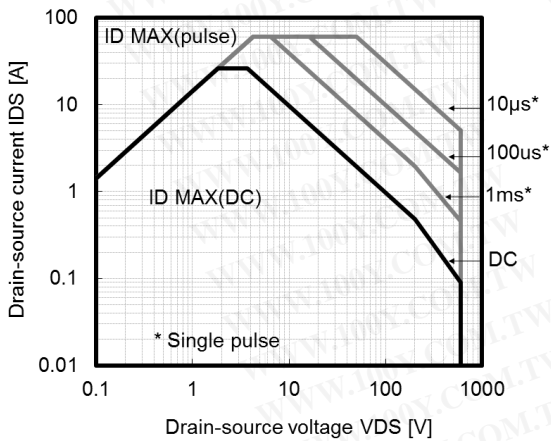
【Figure 1: Pin layout / Equivalent circuit】



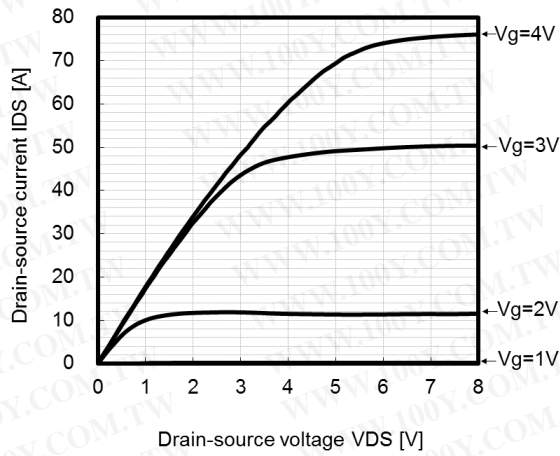
【Figure 2: Max. power dissipation】



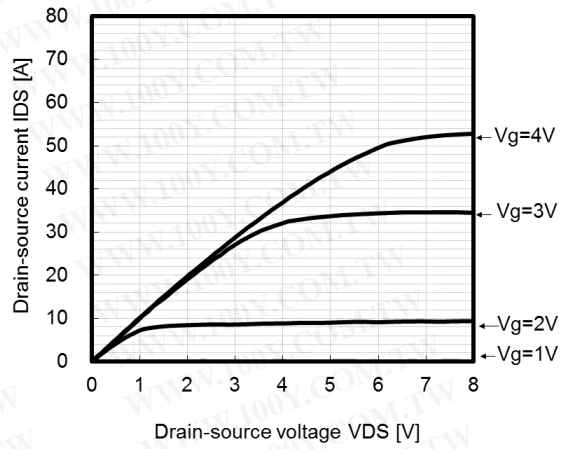
【Figure 3: Transient thermal impedance】



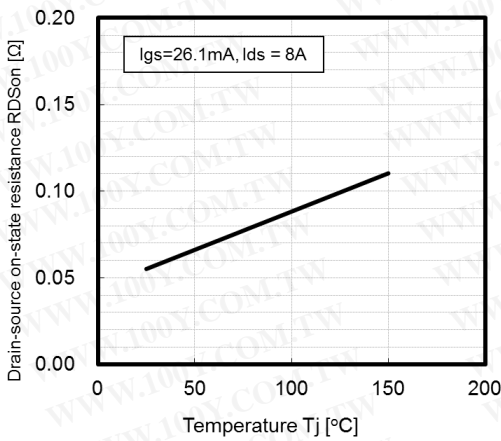
【Figure 4: Safe operating area Tc = 25 °C】



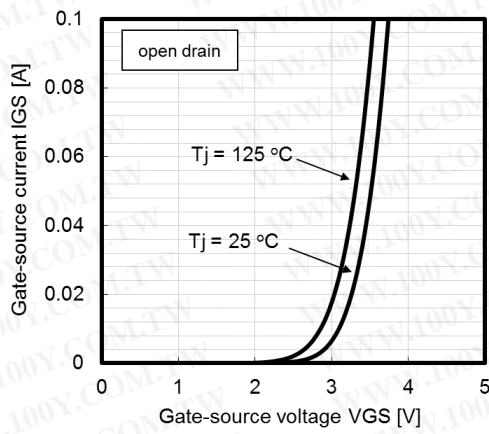
【Figure.5:Output characteristics Tc=25°C】



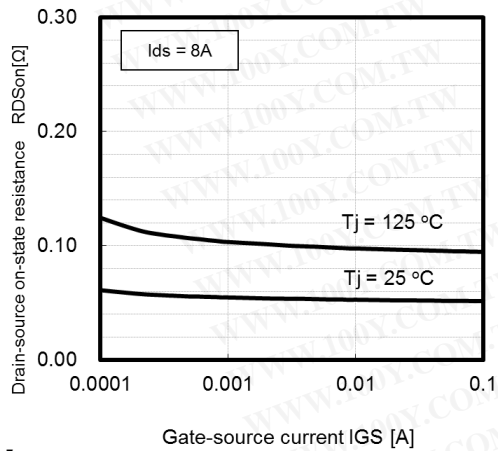
【Figure.6:Output characteristics Tc=125°C】



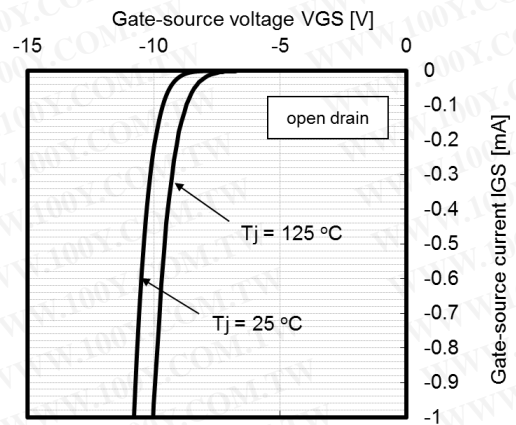
【Figure 7:Drain-source on-state resistance(RDS(on)-Tj)】



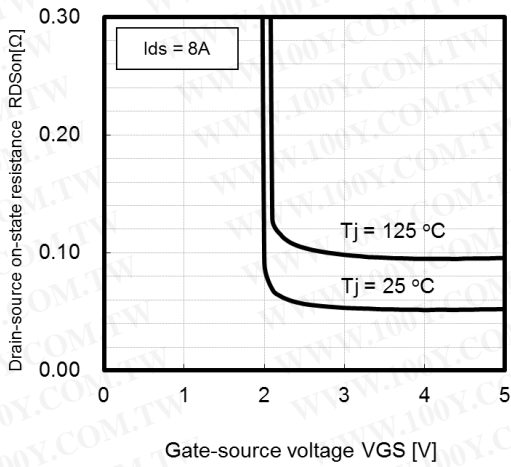
【Figure 8:Gate characteristics】



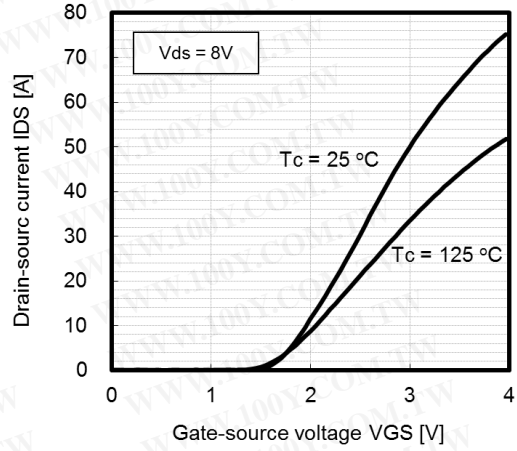
【Figure 9:Drain-source on-state resistance(RDS(on)-IGS)】



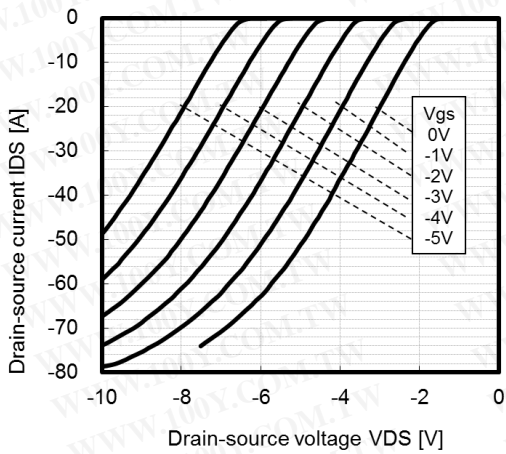
【Figure.10:Gate characteristics】



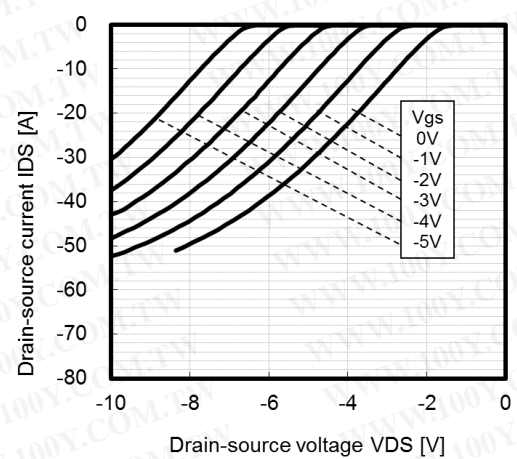
【Figure 11: Drain-source on-state resistance(RDS(on)-VGS)】



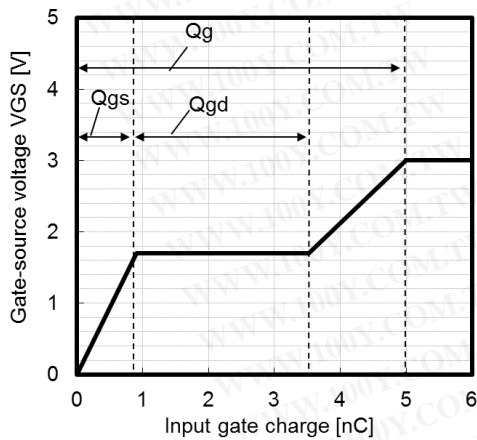
【Figure 12: Transfer characteristics】



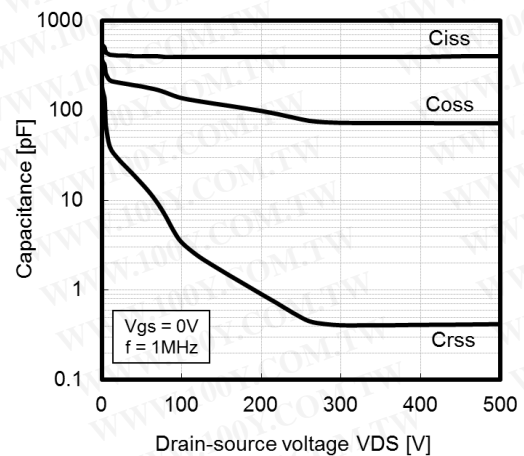
【Figure 13: Reverse channel characteristics (Tc=25°C)】



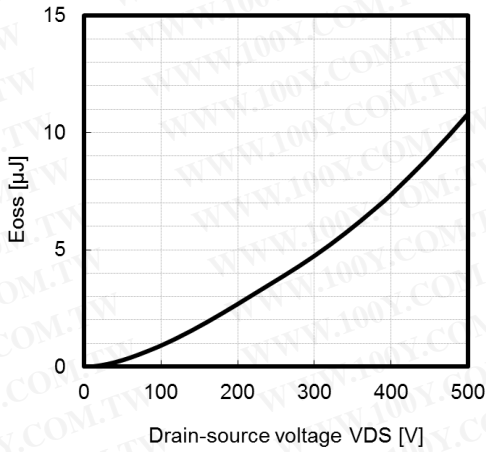
【Figure 14: Reverse channel characteristics (Tc=125°C)】



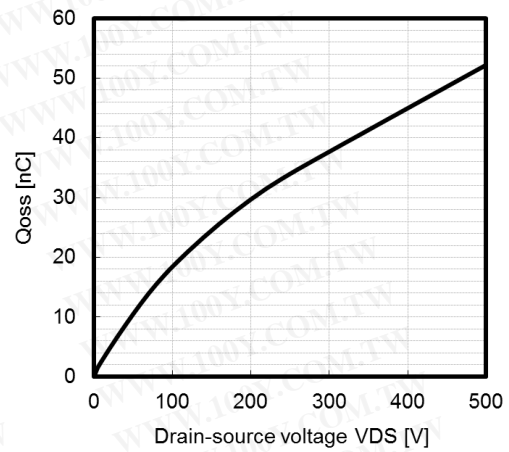
【Figure 15: Gate charge characteristics】



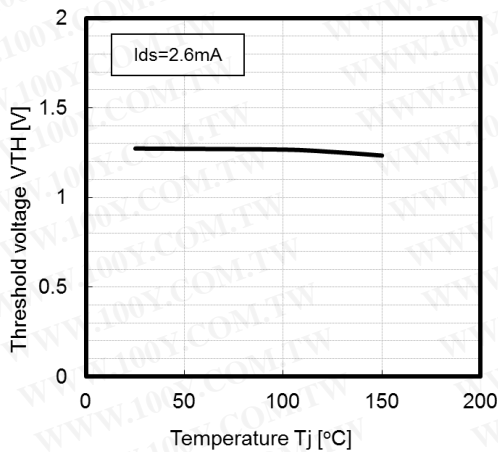
【Figure 16: Capacitance characteristics】



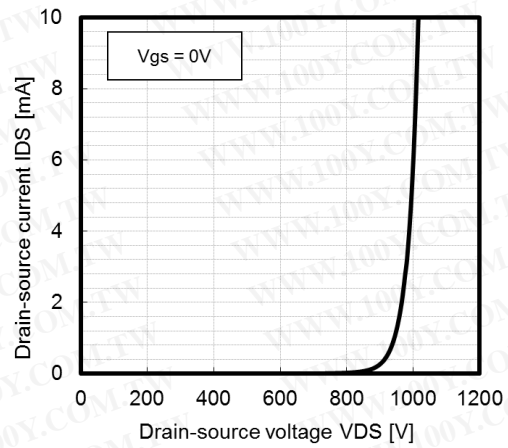
【Figure 17:Output capacitance stored energy】



【Figure 18:Output charge】

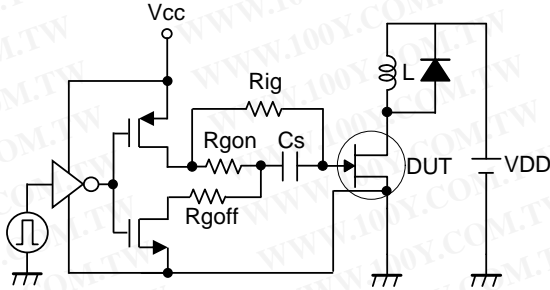


【Figure.19:Threshold voltage (V<sub>TH</sub>-T<sub>j</sub>)】

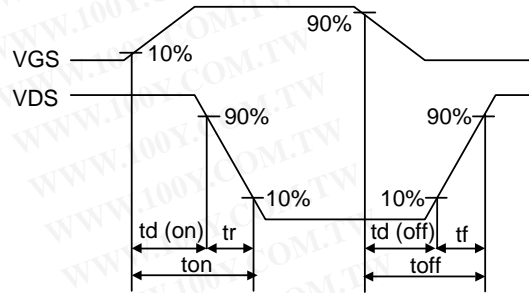


【Figure.20:Drain-Source leakage current (T<sub>c</sub>=25°C)】

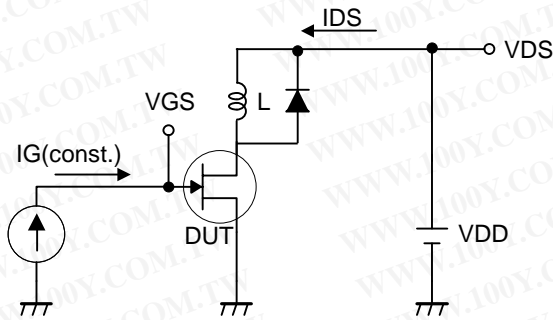




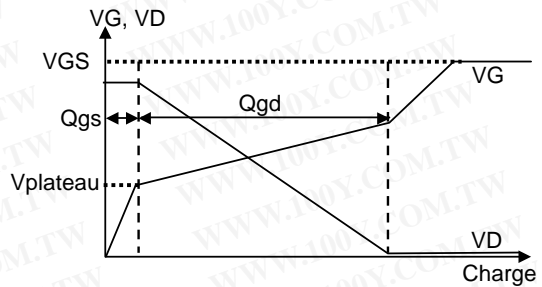
【Figure A : Switching time measurement】



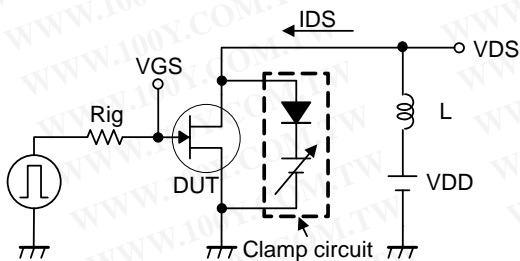
【Figure B : Switching wave form】



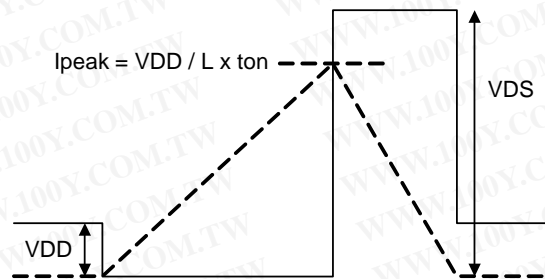
【Figure C : Gate charge measurement】



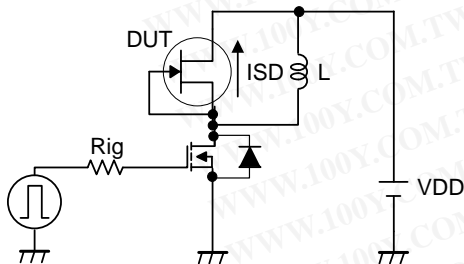
【Figure D : Gate charge wave form】



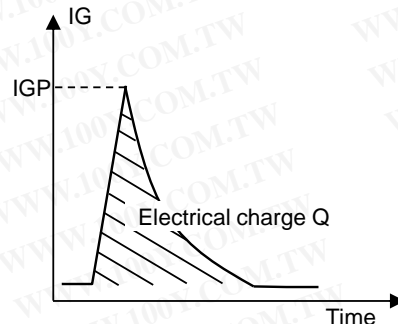
【Figure E : Reverse bias safe operating area dv/dt measurement circuit】



【Figure F : Reverse bias safe operating area dv/dt wave form】



【Figure G : di/dt measurement circuit】



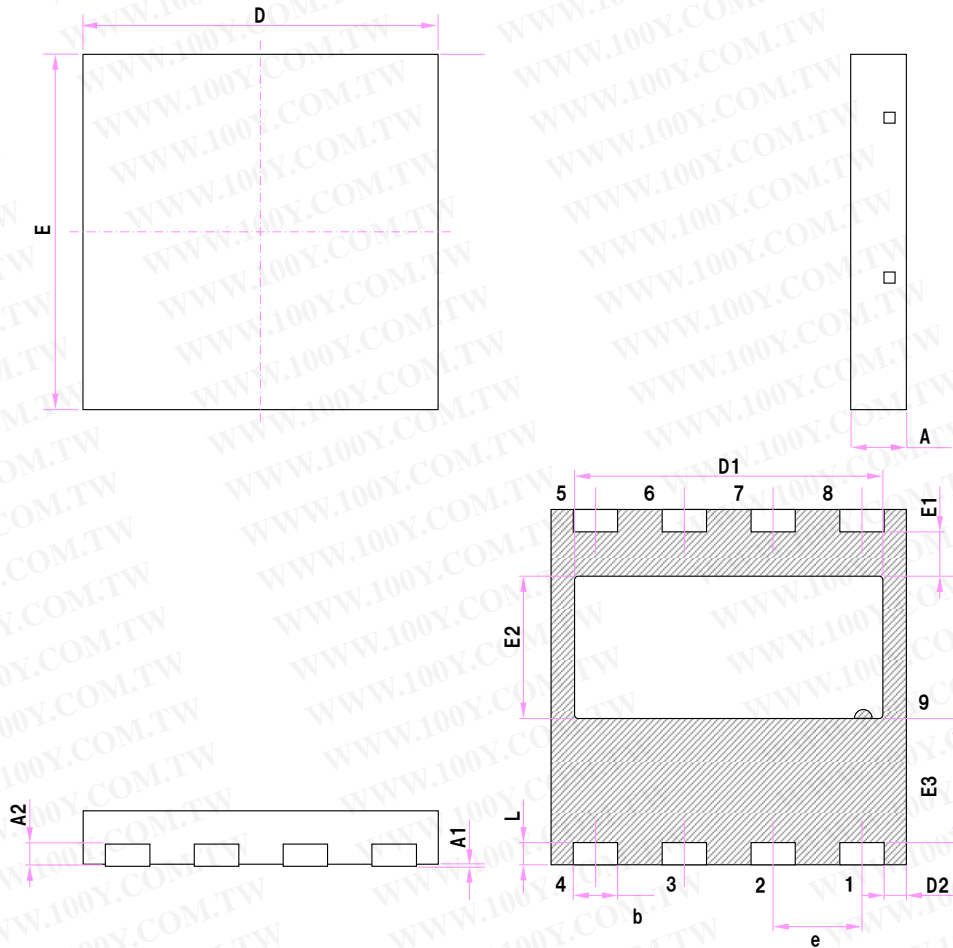
【Figure H : IGP wave form】

[Precautions for Use]

- 1) The product has risks for break-down or burst or giving off smoke in following conditions. Avoid the following use. Fuse should be added at the input side or connect zener diode between Gate pin and GND, etc as a countermeasure to pass regulatory Safety Standard. Concrete countermeasure could be provided individually. However, customer should make the final judgment.
  - (1) Reverse the Drain pin and gate pin connection to the power supply board.
  - (2) Drain pin short to Source1 pin and Source2 pin.
  - (3) Drain pin short to Gate pin.
  - (4) Gate pin open.

■ Outline

Unit: mm



SYMBOL	DIMENSION		
	MIN	NOM	MAX
A	1.15	1.25	1.35
A1	0.00	0.02	0.05
A2	0.40	0.50	0.60
b	0.90	1.00	1.10
D	7.90	8.00	8.10
D1	6.84	6.94	7.04
D2	0.40	0.50	0.60
E	7.90	8.00	8.10
E1	0.90	1.00	1.10
E2	3.10	3.20	3.30
E3	2.70	2.80	2.90
e	2.00 B.S.C.		
L	0.40	0.50	0.60